

Bridge Driver IC

Features

- High Power 3 Phase Bridge Driver for low RDSON N-channel FETs
- 0...100% duty cycle, adjustable without restrictions
- Specified supply voltage range of 5.5 V to 60 V
- Logic operation down to 3 V supply voltage
- High robustness of motor connection pins of -15 V to 90 V
- · Extended protection and supervision functionality
- Serial Peripheral Interface (SPI), control of supervision
- Supervision read out by SPI
- Reverse diode measurement of external FET for temperature detection
- Limp-home functionality of diagnostic and failure behavior with SPI configurable content
- 3 current sense amplifiers for shunt signal conditioning
- 2 switch off paths by pins ENA and SOFF
- Low quiescent current mode by pin INH
- Compatible to 3.3 V μCs and TTL logic
- Phase voltage feedback with SPI programmable voltage thresholds
- Output for phase cut off circuit activation
- Green Product (RoHS compliant)

Product validation

Qualified for Automotive Applications.

Product validation according to AEC-Q100/101.







Bridge Driver IC



Description

Description

The TLE9180D-310K is an advanced gate driver IC dedicated to control 6 external N-channel MOSFETs forming an inverter for high current 3 phase motor drives application in the automotive sector.

A sophisticated high voltage technology allows the TLE9180D-31QK to support applications for single and mixed battery systems with battery voltages of 12 V, 24 V and 48 V even within tough automotive environments in combination with high motor currents. Therefore bridge, motor and supply related pins can withstand voltages of up to 90 V. Motor related pins can even withstand negative voltage transients down to - 15 V without damage.

All low- and high-side output stages are based on a floating concept and its driver strength allows to drive lowest RDSON MOSFETs common on the market. In 12 V applications the gate driver IC is capable of driving 6 MOSFETs, each with a max. total gate charge of QgTOT = 300 nC, at a frequency of up to 20 kHz.

An integrated SPI interface is used to configure the TLE9180D-310K for the application after power-up. After successful power-up parameters can be adjusted by SPI, monitoring data, configuration and error registers can be read. Cyclic redundancy check over data and address bits ensures safe communication and data integrity.

GND related bridge currents can be measured with 3 integrated current sense amplifiers. The outputs of the current sense amplifiers support 5 V ADCs and the robust inputs can withstand negative transients down to -10 V without damage. Gain and zero current voltage offset can be adjusted by SPI. The offset can be calibrated.

Diagnostic coverage and redundancy have increased steadily in recent years in automotive drive applications. Therefore the TLE9180D-31QK offers a wide range of diagnostic features, like monitoring of power supply voltages as well as system parameters. A testability of safety relevant supervision functions has been integrated. Failure behavior, threshold voltages and filter times of the supervisions of the device are adjustable via SPI.

The TLE9180D-31QK is integrated in a LQFP64 package with an exposed pad. Due to its exposed pad the gate driver IC provides an excellent thermal characteristic.

Table 1 **Device Marking**

Туре	Package	Marking
TLE9180D-31QK	LQFP-64	TLE9180D-31QK

TLE9180D-31QK Bridge Driver IC

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Block Diagram

1 Block Diagram

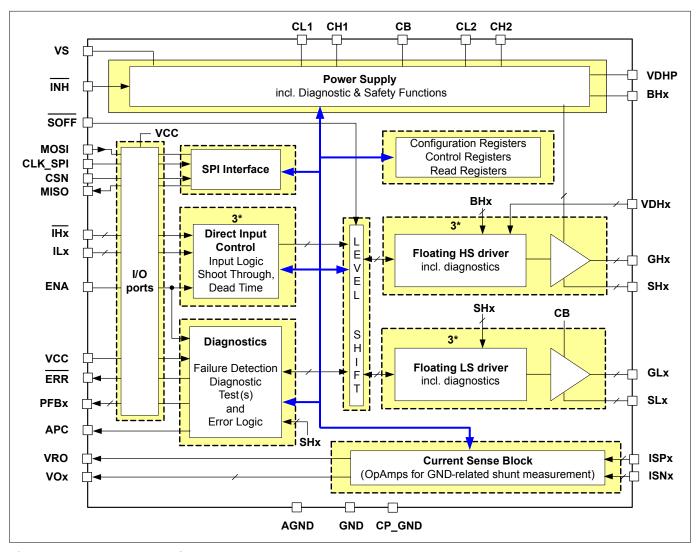


Figure 1 Block Diagram



Pin Configuration

Pin Configuration 2

Pin Assignment 2.1

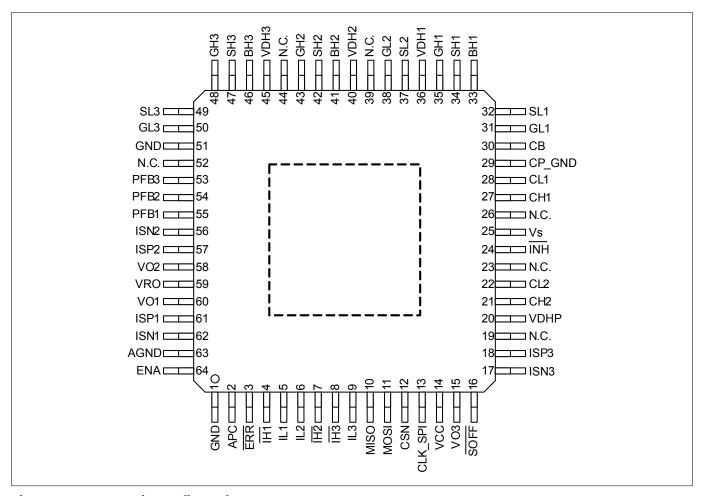


Figure 2 **Pin Configuration**

2.2 **Pin Definitions and Functions**

Pin	Symbol	Function
1	GND	Ground
2	APC	Activation Phase Cut off Circuit
3	ERR	Error Not
4	ĪH1	Input High-side 1 Not
5	IL1	Input Low-side 1
6	IL2	Input Low-side 2
7	ĪH2	Input High-side 2 Not
8	ĪH3	Input High-side 3 Not
9	IL3	Input Low-side 3
10	MISO	Master In Slave Out

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Pin Configuration

Symbol	Function
MOSI	Master Out Slave In
CSN	Chip Select Not
CLK_SPI	Clock Serial Peripheral Interface
VCC	VCC Supply Voltage
VO3	Voltage Output of CSA 3
SOFF	Safe Off Not
ISN3	Input Shunt Negative of CSA 3
ISP3	Input Shunt Positive of CSA 3
N.C.	Not Connected
VDHP	Voltage Drain High-side Power
CH2	Charge Pump 2 High
CL2	Charge Pump 2 Low
N.C.	Not Connected
ĪNH	Inhibit Not
Vs	Voltage Supply
N.C.	Not Connected
CH1	Charge Pump 1 High
CL1	Charge Pump 1 Low
CP_GND	Charge Pump Ground
СВ	Charge Pump Buffer
GL1	Gate Low-side 1
SL1	Source Low-side 1
BH1	Bootstrap High-side 1
SH1	Source High-side 1
GH1	Gate High-side 1
VDH1	Voltage Drain High-side 1
SL2	Source Low-side 2
GL2	Gate Low-side 2
N.C.	Not Connected
VDH2	Voltage Drain High-side 2
BH2	Bootstrap High-side 2
SH2	Source High-side 2
GH2	Gate High-side 2
N.C.	Not Connected
VDH3	Voltage Drain High-side 3
	MOSI CSN CLK_SPI VCC VO3 SOFF ISN3 ISP3 N.C. VDHP CH2 CL2 N.C. INH Vs N.C. CH1 CL1 CP_GND CB GL1 SL1 BH1 SH1 SH1 GH1 VDH1 SL2 GL2 N.C. VDH2 BH2 SH2 SH2 N.C.

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Pin Configuration

Pin	Symbol	Function				
46	ВН3	Bootstrap High-side 3				
47	SH3	Source High-side 3				
48	GH3	Gate High-side 3				
49	SL3	Source Low-side 3				
50	GL3	Gate Low-side 3				
51	GND	Ground				
52	N.C.	Not Connected				
53	PFB3	Phase Voltage Feedback 3				
54	PFB2	Phase Voltage Feedback 2				
55	PFB1	Phase Voltage Feedback 1				
56	ISN2	Input Shunt Negative of CSA 2				
57	ISP2	Input Shunt Positive of CSA 2				
58	VO2	Voltage Output of CSA 2				
59	VRO	Voltage Reference Output				
60	VO1	Voltage Output of CSA 1				
61	ISP1	Input Shunt Positive of CSA 1				
62	ISN1	Input Shunt Negative of CSA 1				
63	AGND	Analog Ground				
64	ENA	Enable				
Cooling Tab	GND	Cooling Tab				

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General Product Characteristics

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3.1 **Absolute Maximum Ratings**

Table 2 **Absolute Maximum Ratings**

 $T_i = -40$ °C to +150°C; all voltages with respect to GND, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test	Number
		Min.	Тур.	Max.		Condition	
Power Supply	1	II.	1			1	
Supply Voltage	V _{Vs1}	-0.3	_	60	V	-	P_4.1.1
Supply Voltage for Power-up	V _{Vs6}	_	_	40	V	-	P_4.1.7
Supply Voltage	V _{Vs2}	-5	_	_	V	Reverse polarity $R_{VS} \ge 10 \Omega^{1}$	P_4.1.2
Voltage Range VDHP	V _{VDHP1}	-5	_	85	V	2)	P_4.1.3
Voltage Difference Vs-VDHP	$V_{\rm dVsVDHP}$	-85	_	60	V	_	P_4.1.5
Voltage Range VDH1, VDH2, VDH3	V _{VDHx1}	-5	_	90	V	_	P_4.1.6
Voltage Difference Vs-VDH1, VDH2, VDH3	$V_{ m dVsVDHx}$	-90	_	60	V	_	P_4.1.8
Voltage Range CL1	V _{CL1}	-0.3	_	60	V	_	P_4.1.9
Voltage Range CH1	V _{CH1}	-0.3	_	28	V	-	P_4.1.10
Voltage Range CB	V_{CB}	-0.3	_	28	V	_	P_4.1.11
Voltage Range CL2, CH2	V _{CHL2}	-0.3	_	90	V	_	P_4.1.12
Voltage Difference CH2-CL2	V _{dCH2CL2}	-0.3	_	28	V	_	P_4.1.62
Maximum Peak Pulse Current CB to CH2	I _{CBCH2}	-	_	1	A	t = 5 μs	P_4.1.61
Maximum Peak Pulse Current CB to BHx	I _{CBBHx}	-	-	1	A	t = 0.8 μs	P_4.1.66
Floating Driver Stages			•				
Voltage Range SLx	V _{SLx1}	-7	_	10	V	_	P_4.1.13
Voltage Range SLx	V _{SLx2}	-10	_	_	V	5)	P_4.1.14
Voltage Range SLx	V _{SLx3}	-15	_	-	V	3)	P_4.1.15
Voltage Range GLx	V _{GLx1}	-7	_	28	V	-	P_4.1.16
Voltage Range GLx	V _{GLx2}	-10	_	_	V	5)	P_4.1.17
Voltage Range GLx	V _{GLx3}	-15	_	_	V	3)	P_4.1.18

¹ Voltage drop via resistor has be to taken into account for applications operating at low battery voltage

² Minimum limit of -5 V valid only for a limited time frame

⁵ For a duration of t_on = 500ns; t_on/t_off = 1% per 20 kHz PWM frequency

³ For a duration of t_on = 250ns; t_on/t_off = 0.5% per 20 kHz PWM frequency

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Absolute Maximum Ratings (continued) Table 2

 $T_i = -40$ °C to +150°C; all voltages with respect to GND, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol		Values		Unit	Note or Test Condition	Number
		Min.	Тур.	Max.	-		
Voltage Range SHx	V _{SHx1}	-7	_	90	V	-	P_4.1.19
Voltage Range SHx	V _{SHx2}	-10	_	_	V	5)	P_4.1.20
Voltage Range SHx	V _{SHx3}	-15	_	_	V	3)	P_4.1.21
Max. Voltage Transients at SHx	V _{fSH_tr1}	_	_	20	V	Slew rate ≤ 1 V/ns	P_4.3.31
Voltage Range GHx	V _{GHx1}	-7	_	90	V	-	P_4.1.22
Voltage Range GHx	V _{GHx2}	-10	_	_	V	5)	P_4.1.23
Voltage Range GHx	V _{GHx3}	-15	-	_	V	3)	P_4.1.24
Voltage Range BHx	V_{BH}	-0.3	_	90	V	-	P_4.1.25
Voltage Difference Gxx-Sxx	V_{GS2}	-0.3	_	28	V	4)	P_4.1.26
Voltage Difference BHx-SHx	V _{BS2}	-0.3	_	28	V	4)	P_4.1.27
Voltage Difference CB-SLx	V _{CBSLx}	-0.3	_	28	V	4)	P_4.1.28
Voltage Difference SHx-SLx	V _{SSx1}	-12	_	90	V	-	P_4.1.29
Voltage Difference VDHP-SHx	V _{dVDHPSHx2}	-90	_	90	V	-	P_4.1.32
Voltage Difference VDHx-SHx	V _{dVDHxSHx}	-90	_	90	V	-	P_4.1.33
Inputs and Outputs		•	•				
Voltage Range ĪHx, ILx, ENA	V _{DIP1}	-0.3	-	60	V	_	P_4.1.34
Voltage Range VCC	V _{VCC1}	-0.3	-	60	V	-	P_4.1.35
Voltage Range INH	V_{INH}	-0.3	_	90	V	-	P_4.1.36
Voltage Range SOFF	V _{SOFF}	-0.3	-	90	V	_	P_4.1.37
Voltage Range PFBx, ERR	V _{DOP1}	-0.3	-	60	V	_	P_4.1.38
Voltage Range APC	V _{AOP1}	-0.3	-	60	V	-	P_4.1.39
SPI Interface							
Voltage Range CLK_SPI, CSN, MOSI	V _{SPI1}	-0.3	_	60	V	_	P_4.1.40
Voltage Range MISO	V _{SPI2}	-0.3	_	60	V	-	P_4.1.41
Shunt Signal Conditioning		•	•				
Voltage Range ISPx, ISNx	V _{ISx1}	-3.0	_	3.0	V	-	P_4.1.42
Voltage Range ISPx, ISNx	V _{ISx2}	-10	-	10	V	$R_{\rm ISP} \ge 18 \Omega$ $R_{\rm ISN} \ge 18 \Omega^{5}$	P_4.1.43

⁵ For a duration of t_on = 500ns; t_on/t_off = 1% per 20 kHz PWM frequency

³ For a duration of t_on = 250ns; t_on/t_off = 0.5% per 20 kHz PWM frequency

For a duration of $t = 50 \mu s$ with 400 mA

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General Product Characteristics

Absolute Maximum Ratings (continued) Table 2

 $T_i = -40$ °C to +150°C; all voltages with respect to GND, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol		Values			Note or Test	Number
		Min.	Тур.	Max.		Condition	
Voltage Difference ISPx-ISNx	V _{dISx}	-5.0	_	5.0	V	_	P_4.1.44
Voltage Range VOx	V _{VOx1}	-0.3	_	3.0	V	_	P_4.1.45
Voltage Range VOx	V _{VOx3}	-0.3	_	5.5	V	INH = High; Vs supplied	P_4.1.46
Voltage Range VOx	V _{VOx2}	-0.3	-	18	V	1 kΩ in series	P_4.1.47
Current Range VOx	I _{VOx}	-10	_	18	mA	_	P_4.1.48
Voltage Range VRO	V _{VRO1}	-0.3	-	3	V	_	P_4.1.49
Voltage Range VRO	$V_{\rm VRO3}$	-0.3	_	5.5	V	INH = High; Vs supplied	P_4.1.50
Voltage Range VRO	V _{VRO2}	-0.3	-	18	V	1 kΩ in series	P_4.1.51
Current Range VRO	I _{VRO}	-10	_	18	mA	_	P_4.1.52
GND					•		
Voltage Range CP_GND, AGND, GND, EPAD	V _{ISx}	-0.3	_	0.3	V	-	P_4.1.53
Temperatures	·	·	•		•		
Storage Temperature	$T_{\rm stg}$	-55	-	150	°C	_	P_4.1.54
Junction Temperature	T_{J1}	-40	-	150	°C	_	P_4.1.55
Junction Temperature	T_{J2}	-40	_	175	°C	200 h over lifetime	P_4.1.56
ESD Susceptibility							
ESD Resistivity HBM all Pins excluded Pin SHx, BHx, GHx, CB, ISNx and ISPx ⁶⁾	V _{ESDHBM1}	-2	_	2	kV	-	P_4.1.57
ESD Resistivity HBM all Pins excluded Pin CB, ISNx and ISPx ⁶⁾	V _{ESDHBM3}	-1.5	-	1.5	kV	-	P_4.1.65
ESD Resistivity HBM all Pins ⁶⁾	V _{ESDHBM2}	-1	_	1	kV	-	P_4.1.58
ESD Resistivity all Pins (charged device model) ⁷⁾	V _{ESDCDM}	-	-	500	V	-	P_4.1.59
ESD Resistivity Corner Pins (charged device model) ⁷⁾	V _{ESDCDMc}	-	-	750	V	-	P_4.1.60

⁶ ESD robustness according to Human Body Model (HBM) ANSI/ESDA/JEDEC JS-001

⁷ ESD robustness according to Charged Device Model (CDM) JESD22-C101

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Notes:

- 1. Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
- Integrated protection functions are designed to prevent IC destruction under fault conditions described in 2. the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

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General Product Characteristics

Thermal Resistance 3.2

Note: This thermal data was generated in accordance with JEDEC JESD51 standards. For more information,

go to www.jedec.org.

Table 3 **Thermal Resistance**

Parameter	Symbol		Values	;	Unit	Note or Test	Number
		Min.	Тур.	Max.		Condition	
Junction to Case ⁸⁾	R _{thJC}	-	5	-	K/W	$V_{\rm VS} = V_{\rm VDH} = 14 \rm V;$ $T_{\rm a} = 85^{\circ} \rm C; 6 \rm FETs$ toggling: $Q_{\rm gTOT} = 200 \rm nC;$ $f_{\rm PWM} = 20 \rm kHz;$ inhomogeneous power distribution	P_4.2.1
Junction to Top ⁸⁾	R _{thJCT}	-	18	-	K/W	$V_{\rm VS} = V_{\rm VDH} = 14 \rm V;$ $T_a = 85^{\circ} \rm C; 6 FETs$ toggling: $Q_{\rm gTOT} = 200 \rm nC;$ $f_{\rm PWM} = 20 \rm kHz;$ inhomogeneous power distribution	P_4.2.2
Junction to Ambient ⁸⁾	R_{thJA}	-	28	-	K/W	$V_{VS} = V_{VDH} = 14 \text{ V};$ $T_a = 85^{\circ}\text{C}; 6 \text{ FETs}$ toggling: $Q_{gTOT} = 200 \text{ nC};$ $f_{PWM} = 20 \text{kHz};$ inhomogeneous power distribution ⁹⁾	P_4.2.3

⁸ Not subject to production test, specified by design

Specified $R_{\rm thJA}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; The product (chip + package) was simulated on a 76.2 × 114.3 ×1.5 mm board with 2 inner copper layers (2 × $70 \, \mu m \, Cu$, $2 \times 35 \, \mu m \, Cu$). Where applicable a thermal via array under the exposed pad contacted the first inner copper layer

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General Product Characteristics

3.3 Functional Range

Table 4 Functional Range

 T_j = -40°C to +150°C; all voltages with respect to GND, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol		Value	S	Unit		Number
	Min. Typ. Max.			Condition			
Supply Voltage	V _{Vs3}	5.5	_	60	V	Thermally limited	P_4.3.1
Supply Voltage for Startup	V _{Vs4}	V_{VsWU}	-	_	V	Startup	P_4.3.2
Supply Voltage Reduced Operation Range Vs ¹⁰⁾	V _{Vs5}	3.0	-	$V_{\rm VsROP}$	V	Logic operational; I/Os turned off	P_4.3.3
Voltage Range VCC	V _{VCC4}	V _{VCCROP}	-	$V_{VCCxOVx}$	V	-	P_4.3.4
Supply Voltage Reduced Operation Range VCC	V _{VCC5}	-0.3	-	V _{VCCROP}	V	Logic operational; I/Os turned off	P_4.3.5
Voltage Range CB ¹¹⁾	V_{fCB}	V _{CBUVSD}	-	15.0	V	-	P_4.3.6
Voltage Difference CH1-CL1 ¹¹⁾	V _{CP1}	V _{CBx} - V _s	-	V_{CBd}	V	INH = High; CP1 and CP2 operative	P_4.3.7
Voltage Difference CH2-CL2 ¹¹⁾	V _{CP2}	-0.3	-	V_{CBd}	V	INH = High; CP1 and CP2 operative	P_4.3.8
Voltage Difference CH1-CL1 ¹¹⁾	V _{CP1b}	-0.3	_	V_{CBd}	V	INH = Low or CP1 off	P_3.3.2
Voltage Difference CH2-CL2 ¹¹⁾	V _{CP2b}	-0.3	_	V_{CBd}	V	INH = Low or CP2 off	P_3.3.3
Voltage Range VDHP, VDH1, VDH2, VDH3	V _{VDH3}	4.0	-	V_{VDHOVSD}	V	PFBx- operational	P_4.3.27
Voltage Range VDHP, VDH1, VDH2, VDH3	V _{VDH4}	2.0	_	$V_{\rm VDHOVSD}$	V	VDHP readout- operational	P_4.3.28
Voltage Range VDHP, VDH1, VDH2, VDH3	V _{VDH5}	0.0	-	V _{VDHOVSD}	V	CP2 and SCD- operational ¹²⁾	P_4.3.29
Voltage Range SHx	V_{fSHx}	-V _{BHSHxx}	-	90V- V _{BHSHxx}	V	-	P_4.3.9
Voltage Difference BHx-SHx	V_{fBS1}	V_{BSUV}	_	V_{fCB}	V	Bootstrap charging	P_4.3.10
Voltage Difference BHx-SHx	V_{fBS2}	V_{BSUV}	_	V _{BHSHxlim}	V	CP2 charging	P_4.3.30
Voltage Difference Gxx-Sxx	V_{fGS1}	-0.3	_	15.0	V	-	P_4.3.11
Duty Cycle Range Output Stages	D.C.	0	_	100	%	_	P_4.3.12
Voltage Range INH	V _{AIP1}	-0.3	_	V _{VCCxOVx}	V	-	P_4.3.13
Voltage Range SOFF	V _{AIP2}	-0.3	-	$V_{VCCxOVx}$	V	_	P_4.3.14

¹⁰ Power-up to be completed first

Max. value will not be exceeded under normal operation condition, voltage class of charge pump capacitor can be selected accordingly

At minimum limit charge pumps are operational even if freewheeling current flows via the reverse diode of the external high-side FET

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Functional Range (continued) Table 4

 $T_i = -40$ °C to +150°C; all voltages with respect to GND, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol		Values			Note or Test	Number
		Min.	Тур.	Max.		Condition	
Voltage Range IHx, ILx, ENA, CLK_SPI, CSN, MOSI	V _{DIP2}	-0.3	-	$V_{\text{VCC} \times \text{OV} \times}$	V	-	P_4.3.15
Voltage Range PFBx, ERR, MISO	V _{DOP2}	V _{ERRL} V _{SPIL}	-	V _{ERRHx} V _{SPIHx}	V	-	P_4.3.16
Output Impedance PFBx, ERR	R _{DOP}	_	50	_	Ω	-	P_4.3.17
Output Impedance MISO	R _{DOPMISO}	_	130	_	Ω	_	P_3.3.1
Voltage Range APC	V _{AOP2}	-0.3	_	V _{AOPHx}	V	-	P_4.3.18
Current Range APC	I _{AOP2}	-1	_	1	mA	-	P_4.3.19
Input Voltage Range ISPx, ISNx	V_{fISx}	V _{SSC_CM}	_	V _{SSC_CM}	V	-	P_4.3.20
Differential Voltage Range ISPx, ISNx	V _{fdiffISx}	V _{SSC_Idiff}	-	V _{SSC_Idiff}	mV	-	P_4.3.21
Voltage Range VOx	V_{fVOx}	V _{SSC_OVR}	_	V _{SSC_OVR}	V	_	P_4.3.22
Voltage Range VRO	V_{fVRO}	V _{SSC_OVRO}	_	V _{SSC_OVRO}	V	_	P_4.3.24

Note:

Within the functional or operating range, the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the Electrical Characteristics table.

Input and Output Characteristics



4 Input and Output Characteristics

The input and output pins of the TLE9180D-31QK drive the output stages and give feedback to the μ C about the state of the gate driver IC, the μ C and the state of the inverter stage. Digital in- and outputs are supplied out of VCC and refer to the VCC voltage, general in- and outputs have fixed input threshold and fixed output high levels. Every output stage driving an external FET has its own input pin. Additionally there are 3 different pins to activate or deactivate the output stages. The impact of the 3 pins ENA, $\overline{\text{INH}}$ and $\overline{\text{SOFF}}$ differs from each other regarding to the gate driver IC's reaction. With the SPI interface the TLE9180D-31QK can be configured and diagnostics can be read out by the μ C. The $\overline{\text{ERR}}$ pin indicates a failure of the TLE9180D-31QK or the system.

Table 5 I/Os functionality

Name of I/O	Definition	Functionality	Default State
ĪNH	General Input	Sleep Mode	Internal pull-down, FETs off passive clamping, Power up/down of device
SOFF	General Input	Safe switch off	Internal pull-down, FETs off without reset of error registers, SOFF mode
ILx	Digital Input	Driver input for LS FETs	Internal pull-down, Affected FET off
ĪHx	Digital Input	Driver input for HS FETs	Internal pull-up to VCC, Affected FET off
ENA	Digital Input	Enable and Reset	Internal pull-down, All FETs off
CLK_SPI	Digital Input	SPI	Internal pull-down
MOSI	Digital Input	SPI	Internal pull-down
CSN	Digital Input	SPI	Internal pull-up to VCC
MISO	Digital Output	SPI	Push-pull stage to VCC, Tri-state (Hi-Z) in case of no supply or if deactivated
PFBx	Digital Output	Phase Feedback	Push-pull stage to VCC with internal pull-down
APC	General Output	Driving Phase Cut Off Circuit	Push-pull stage to 5 V with internal pull-down
ERR	Digital Output	Diagnostic Output	Push-pull stage to VCC with internal pull-down

Serial Peripheral Interface - SPI



5 Serial Peripheral Interface - SPI

The 24-bit Serial Peripheral Interface (SPI) enables a communication link of the μ C as SPI-master and the TLE9180D-31QK. The SPI interface is used to configure and to control the gate driver IC and to read out of the status registers.

The SPI interface in the TLE9180D-31QK is a SPI-Slave. It always requires a SPI-Master. This is usually a μ C. The master generates the CLK_SPI and CSN signals used for data transfer and its synchronization.

The SPI interface can operate in bus application mode with additional SPI-Slave devices. Daisy Chain is not possible, as incoming data is not passed directly to the output port. The transmission format of incoming and outcoming SPI frames differ.

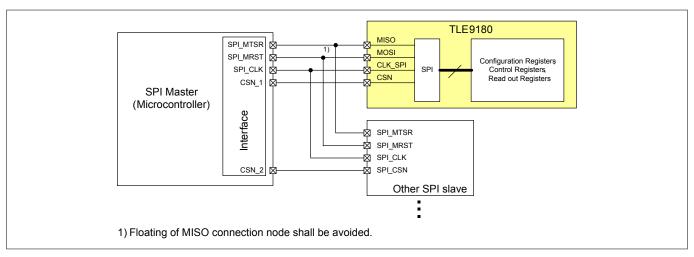


Figure 3 Principle for SPI-Bus Architecture



6 Power Supply

Power to the TLE9180D-31QK is supplied by pins Vs and VCC. The VCC supplies the digital I/O ports. All other supply voltages for the low- and high-side output stages, the digital and analog circuits and the gate voltage to drive the external MOSFETs are generated internally.

Additionally the TLE9180D-31QK is designed to operate with different supply voltages for the gate driver IC pin Vs and the power inverter stage at pin VDHP. Functional limitation of supply voltage differences between pin VDHP and the Vs supply is only their respective maximum ratings. Next to single supply systems typical environment is a boosted system for the power inverter while the gate driver is running with single battery supply voltage or a regulated supply voltage.

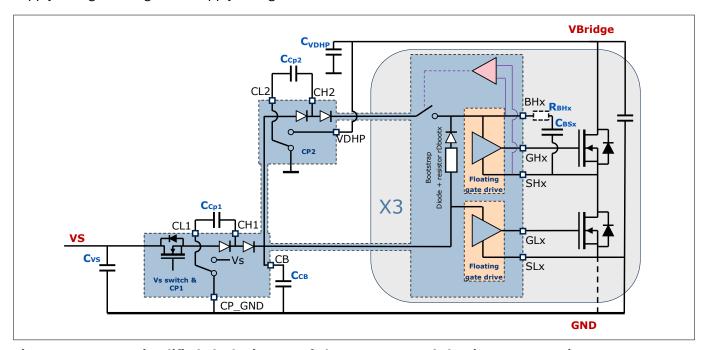


Figure 4 Simplified Block Diagram of Charge Pumps and Floating MOSFET Driver

Bridge Driver IC



Floating MOSFET Driver

Floating MOSFET Driver 7

The TLE9180D-31QK provides 6 identical output stages to drive external N-channel MOSFETs in a brushless DC motor configuration. The driving signal for each FET given by the μC will be referenced to the source of every single FET by the integrated level shifters. The pins SLx/SHx are the reference for the floating gate driver output stages. A shoot through protection and dead time control is integrated into the logic. Violation of the input patterns and the correct conversion of the GND related input signal into floating signal by the level shifter will be monitored. Additionally the design and layout of the 6 internal signal paths for gate driving are integrated similar to each other to minimize switching and propagation delay time differences.

Shunt Signal Conditioning



8 Shunt Signal Conditioning

The shunt signal conditioning (SSC) incorporates 3 precise current sense amplifiers (CSAs) to amplify the voltage drop at the shunt resistors caused by the motor currents and a voltage reference output buffer (RB), see *Figure 5*.

The signal conditioning refers to GND. Due to high common mode input voltage range it is robust against sense voltage ringing caused by stray inductances during fast PWM current switching. Due to high common mode functional input voltage range it is robust against high common mode shifts between the GNDs of the shunts and the common GND of the ECU.

High equivalent input resistances, low input offset voltages and low gain error provide an excellent DC performance of the CSAs and therefore minimizes the total error of the shunt signal conditioning.

Additionally, high common mode rejection ratio, high power supply rejection ratio and a low noise figure of the CSAs contribute to minimize the total error of the SSC.

In order to optimize the shunt signal conditioning - especially in systems designed for a wide motor current range with high accuracy requirements at high and low motor currents - different gains can be programmed.

The DC output voltage at the outputs of the CSAs (VOx) for zero differential input voltage is defined by the output of the reference buffer at pin VRO. Therefore, positive and negative currents through the shunt resistor can be amplified by the CSAs and thus measured by the ADC of μ C. Three different VRO voltages can be set at the reference buffer RB. Each of the three VRO voltage settings can be fine tuned.

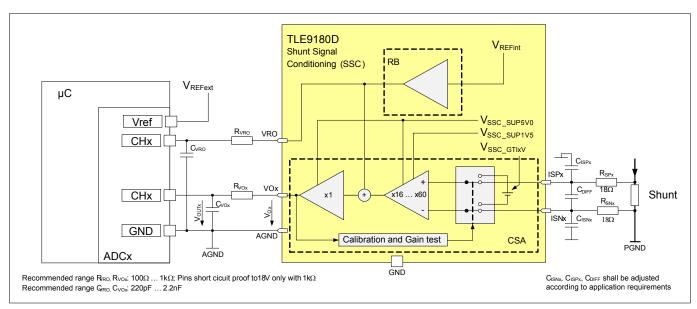


Figure 5 Simplified Block- and Application Diagram of the Shunt Signal Conditioning

TLE9180D-31QK Bridge Driver IC



Protection and Diagnostics

9 Protection and Diagnostics

The TLE9180D-31QK provides extended protection and monitoring functions. All detected errors and warnings can be read by SPI, most of the thresholds are selectable by SPI configuration or SPI command. Safety relevant diagnostics can be tested during operation in a dedicated self-test mode.

9.1 Supervision Overview

The following diagnostics and read out functions are available.

Table 6 Diagnostic overview

Diagnostic	Availability in Configuration	Availability in reduced operation	Availability with SOFF=low	Test of Diagnosis Function
Power Supply Supervision a	and Diagnostics	,	'	
Overvoltage VS (Programmable Threshold)	yes (default value)	no	yes	no
Overvoltage VS shutdown	yes	no	yes	no
Undervoltage VS (Programmable Threshold)	yes (default value)	no	yes	no
VS Read Out	yes	no	yes	no
Overvoltage VDHP (Programmable Threshold)	yes (default value)	no	yes	no
Overvoltage LD VDHP	yes (default value)	no	yes	no
Overvoltage VDHP Shutdown	yes	no	yes	no
Undervoltage VDHP (Programmable Threshold)	yes (default value)	no	yes	no
VDHP Read Out	yes	no	yes	no
VCC Under- and Over Monitoring	yes	no	yes	yes
VCC Read Out	yes	no	yes	no
Output Stage Power Supply	Supervision			•
Undervoltage Charge Pump CB Shutdown	yes	no	yes	no
Undervoltage Charge Pump CB (prog. threshold)	yes (default value)	no	yes	no
CB Read Out	yes	no	yes	no
Overvoltage Charge Pump 1	yes	no	yes	no
Overvoltage Charge Pump 2 CH2-CL2	yes	no	yes	no
Overload Vs	yes	no	yes	no
Overload Charge Pump 1	yes	no	yes	no

Bridge Driver IC



Protection and Diagnostics

Diagnostic overview (continued) Table 6

Diagnostic	Availability in Configuration	Availability in reduced operation	Availability with SOFF=low	Test of Diagnosis Function
Overload Charge Pump 2	yes	no	yes	no
Undervoltage High-side Buffer Capacitor BHx-SHx	yes	no	yes	no
Overvoltage High-side Buffer Capacitor BHx-SHx	yes	no	yes	no
Gate Driver Internal Superv	isions			
nternal Power Supply Monitoring	yes	no	yes	no
Clock Supervision (internal clock)	yes	no	yes	no
Overtemperature Shutdown	yes	no	yes	no
Overtemperature Detection (Programmable Threshold)	yes (default value)	no	yes	no
Temperature Read out	yes	no	yes	no
CSA Diagnostics	no	no	no	n.a.
Output Stage Status Feedback Information	no	no	yes	no
Digital Driving Path Monitoring	yes	no	yes	no
Latent Fault Warning Monitoring	yes	no	yes	no
Bridge and FET Diagnostics	and Protection			
Shoot Through Protection	n.a.	n.a.	n.a.	n.a.
SCD Failure	no	no	no	yes
FET Drain Source Voltage Read out	n.a.	n.a.	n.a.	n.a.
FET Reverse Diode Forward Voltage Read out	n.a.	n.a.	n.a.	n.a.
Overcurrent Detection	yes	no	yes	no
Drain Source Measurement	no	no	no	n.a.
nterface to μC Supervision				
nput Pattern Violation Monitoring	n.a.	n.a.	n.a.	no
Overload Digital Output Pins	yes	no	yes	no
Configuration Signature Invalid	yes	yes	yes	no

Bridge Driver IC



Protection and Diagnostics

Diagnostic overview (continued) Table 6

Diagnostic	Availability in Configuration	Availability in reduced operation	Availability with SOFF=low	Test of Diagnosis Function
Configuration Time-out	yes	no		no
SPI Frame Error	yes	n.a.	yes	no
SPI Frame Time-out	yes	n.a.	yes	no
SPI Window Watchdog Time- out	no	no	yes	n.a.
CRC error (incoming data)	yes	n.a.	yes	no
Invalid Address Access	yes	n.a.	yes	no

Bridge Driver IC



Digital Phase Voltage Feedback

Digital Phase Voltage Feedback 10

The TLE9180D-31QK incorporates a fast conversion of the phase voltages into logic level signals. Its threshold values are proportional to the voltage at pin VDHP as long as the VDHP voltage is below 60 V and stays above 4.0 V. The outputs are VCC push-pull stages with an internal pull down resistor. The phase voltage feedback is realized functional independent to the core logic. If the digital phase feedback is not used the output pins shall be open.



11 Operation Modes

This chapter describes the different operation modes.

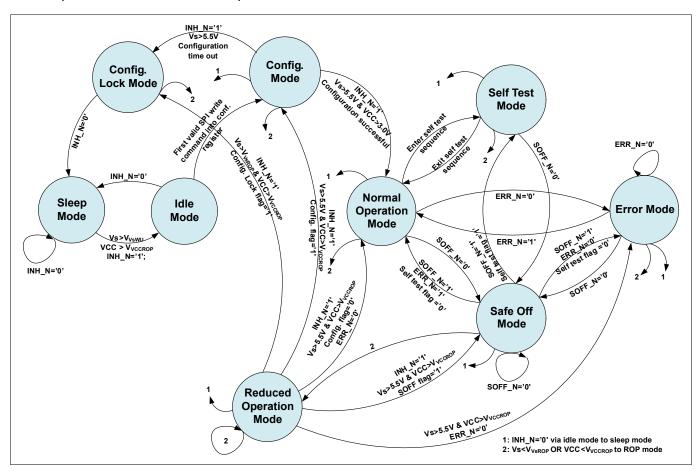


Figure 6 Overview of Digital Operation Modes

Application Information



12 Application Information

In this application 3 phase motors, synchronous and asynchronous, are used, combining high output performance, low space requirements and high reliability.

Note: The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.

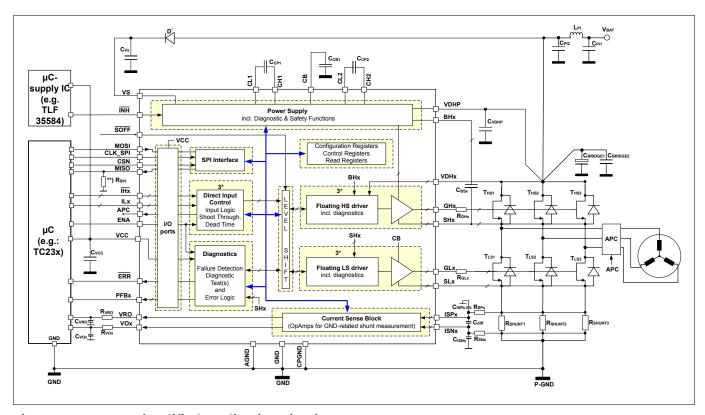


Figure 7 Simplified Application Circuit

Note: This is a very simplified example of an application circuit. The function must be verified in the real application.

Package Outlines

13 Package Outlines

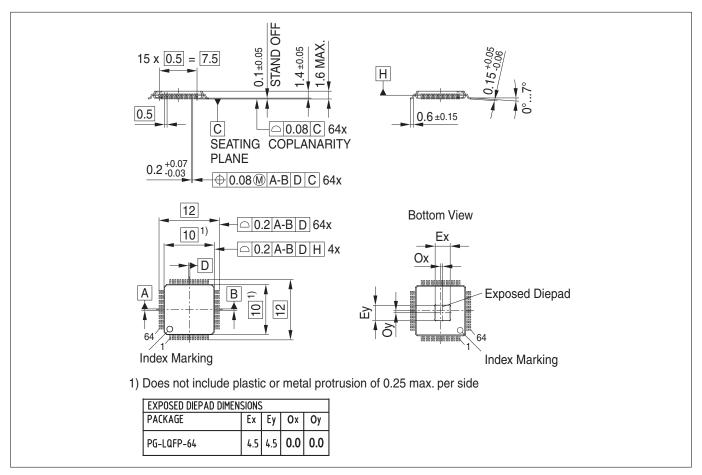


Figure 8 PG-LQFP-64

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pbfree finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

For further information on alternative packages, please visit our website: http://www.infineon.com/packages.

Dimensions in mm

Bridge Driver IC



Revision History

Revision History

Revision	Date	Changes
1.0	2019-03-15	Initial product summary

Trademarks

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